

Search Notes



Application/Control No.

10/622,649

Examiner

James Phan

Applicant(s)/Patent under Reexamination

SEKI ET AL.

Art Unit

2872

SEARCHED

Class	Subclass	Date	Examiner
359	204	2/05	J.P.
250	234-		
	236		
	216		
	578.1		
347	233-		
	236		
358	474		
	483		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
All above		2/05	J.P.

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST. See attachment	2/05	J.P.